FO	RM	PT	O-1	449

## U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

## PATENT AND TRADEMARK OFFICE

## LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

	2
ATTORNEY DOCKET NO.	APPLICATION NO
826.1772	¥7.9
FIRST NAMED INVENTOR	99.
Katsuhito FUJIMOTO, et al.	\$6 <b>\_</b> 1
FILING DATE	GROUP ART UNIT
November 27, 2001	GROOF ARTICIPATE

**U.S. PATENT DOCUMENTS** 

U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE	
	AA							
	АВ							
	AC							
	AD							
	AE							
	AF							

**FOREIGN PATENT DOCUMENTS** 

TOKEIGHT ATEM DOCUMENTO								
		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANS YES	NO
	AG							
	АН							
	Al							
	AJ							
	AK							
	AL							

OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

	E	АМ	Øivind Due Trier, et al., "Goal-Directed Evaluation of Binarization Methods", IEEE Transactions on Pattern Analysis and Machine Intelligence, Vol. 17, No. 12, pp. 1191-1201.
Γ	<del></del>	AN	
L		1	
I		AO	
ı		1	

		/		A
EXAMINER	My K		DATE CONSIDERED	10/8/04

EXAMINER: Initial interesting considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.







	CALL
FORM	PTO-1449

U.S. DEPARTMENT OF COMMERCE

ATTORNEY DOCKET NO.

FIRST NAMED INVENTOR

Sheet 1 of 1

PATENT AND TRADEMARK OFFICE

826.1772

09/944,792

LIST OF REFERENCES CITED BY APPLICANT

Katsuhito FUJIMOTO, et al.

FILING DATE

GROUP ART UNIT

(Use several sheets if necessary)

November 27, 2001

ILS PATENT DOCUMENTS

U.S. PATENT DOCUMENTS								
*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE	
1	AA	5,915,037	06/22/99	Weber et al.				
A	AB	5,889,885	03/30/99	Moed et al.				
A	AC	5,054,101	10/01/91	Prakash	REC	EIVE	D	
	AD				JUN	0 2 2004		
	AE				Technolog	y Center 2	600	
	AF							

**FOREIGN PATENT DOCUMENTS** 

		DOCUMENT	1		T	SUB-	TRANSL	ATION
		NO.	DATE	COUNTRY	CLASS	CLASS	YES	NO
80	AG	00/77718 A1	12/21/00	WIPO			Abstract	
Y	АН	1144587 A	03/05/97	China			Abstract	
	Al							
	AJ							
	AK							
	AL							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)			
AM			

**EXAMINER** 

DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.